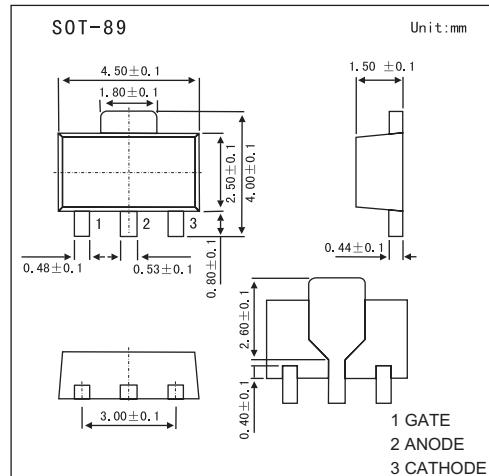
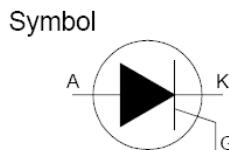


Silicon Controlled Rectifiers

HBT169M

■ Features

- Repetitive peak off-state voltages :400V
- Average on-state current :0.5A
- RMS on-state current :0.8A
- Non-repetitive peak on-state current :8A



■ Absolute Maximum Ratings Ta = 25°C

Parameter	Symbol	Rating	Unit
Peak Repetitive Forward and Reverse Blocking Voltage*	V _{DRM} and V _{RRM}	400	V
Forward Current RMS	I _{T(RMS)}	0.8	A
Non-repetitive peak on-state current (t=10ms)	I _{TSM}	8	A
Non-repetitive peak on-state current (t=8.3ms)	I _{TSM}	9	A
Circuit Fusing Considerations (t = 10ms)	I ² t	0.32	A ² s
Repetitive rate of rise of on-state current after triggering *1	dIT/dt	50	A/us
Peak gate current	I _{GM}	1	A
Peak Gate Power — Forward, TA = 25°C	P _{GM}	2	W
Average Gate Power — Forward, TA = 25°C	P _{GF(AV)}	0.1	W
Peak Gate Current — Forward, TA = 25°C	I _{GFM}	1	A
Peak gate voltage	V _{GM}	5	V
Peak Gate Voltage — Reverse	V _{GRM}	5	V
Thermal resistance junction to lead *2	R _{th j-lead}	60	K/W
Thermal resistance junction to ambient *2	R _{th j-a}	150	K/W
Storage temperature	T _{stg}	150	°C
Operating junction temperature	T _J	125	°C

*1 I_{TM}=2A; I_G=10mA; dI_T/dt=100mA/us

*2 pcb mounted;lead length=4mm

HBT169M

■ Electrical Characteristics ($T_a = 25^\circ\text{C}$, unless otherwise noted.)

Parameter	Symbol	Testconditons	Min	Typ.	Max	Unit
On-state Voltage	V_T	$I_T=1\text{A}$		1.2	1.35	V
Gate Trigger Current (Continuous dc)*2 $T_c = 25^\circ\text{C}$	I_{GT}	$V_D=12\text{V}, I_T=10\text{mA}, \text{Gate open circuit}$		50	200	μA
Latching Current	I_L	$V_D=12\text{V}, I_{GT}=0.5\text{mA}; R_{GK}=1\text{k}\Omega$		2	6	mA
Holding Current	I_H	$V_D=12\text{V}, I_{GT}=0.5\text{mA}; R_{GK}=1\text{k}\Omega$		2	5	mA
Gate Trigger Voltage	V_{GT}	$V_D=12\text{V}, I_T=10\text{mA}, \text{Gate open circuit}$ $V_D=V_{DRM}(\text{max}), I_T=10\text{mA}; T_j=125^\circ\text{C}, \text{Gate open circuit}$	0.2	0.5 0.2	0.8	V
Off-state Leakage Current	$I_{D,IR}$	$V_D=V_{DRM}(\text{max}); V_R=V_{RRM}(\text{max}); T_j=125^\circ\text{C}; R_{GK}=1\text{k}\Omega$		0.05	0.1	mA
Critical rate of rise of off-state voltage	dV_D/dt	$V_{DM}=67\% V_{DRM}(\text{max}); T_j=125^\circ\text{C}, \text{exponential waveform}; R_{GK}=1\text{k}\Omega$	500	800		V/us
Gate controlled turn-on time	t_{gt}	$I_{TM}=2\text{A}; V_D=V_{DRM}(\text{max}), G=10\text{mA}; dI_G/dt=0.1\text{A}/\text{us}$		2		us
Circuit commutated turn-off time	t_q	$V_D=67\% V_{DRM}(\text{max}); T_j=125^\circ\text{C}, T_M=1.6\text{A}; V_R=35\text{V}; dI_{TM}/dt=30\text{A}/\text{us}, dV_D/dt=2\text{V}/\text{us}; R_{GK}=1\text{k}\Omega$		100		us

*1. Forward current applied for 1 ms maximum duration, duty cycle $\leqslant 1\%$.

*2. R_{GK} current is not included in measurement.

■ Marking

Marking	169
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HBT169M